

Evidence for Resonant Scattering of Electrons by Spin Fluctuations in $\text{LaNiO}_3/\text{LaAlO}_3$ Heterostructures Grown by Pulsed Laser Deposition¹

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Received July 30, 2015; in final form, August 5, 2015

We present measurements of resistivity ρ in highly oriented LaNiO_3 films grown on LaAlO_3 substrates by using a pulsed laser deposition technique. The experimental data are found to follow a universal $\rho(T) \propto T^{3/2}$ dependence for the entire temperature interval ($20 \text{ K} < T < 300 \text{ K}$). The observed behavior has been attributed to a resonant scattering of electrons on antiferromagnetic fluctuations (with a characteristic energy $\hbar\omega_f \simeq 2.1 \text{ meV}$) triggered by spin-density wave propagating through the interface boundary of $\text{LaNiO}_3/\text{LaAlO}_3$ sandwich.

DOI: 10.1134/S0021364015180125

1. INTRODUCTION

Even though LaNiO_3 (LNO) belongs to the nickelates family RNiO_3 (with R being a rare-earth element), it possesses unique physical properties because it does not undergo a metal-insulator transition (MIT) from paramagnetic (PM) metal to anti-ferromagnetic (AFM) insulator like all the other members of this family. It stays PM metal for all temperatures. However, recent investigations (see, e.g., [1–5] and further references therein) suggest that one can significantly modify LNO properties by depositing it on different substrates. This can be achieved by thickness controlled partial suppression of the charge ordering (which is believed to be responsible for manifestation of MIT in nickelates). The most interesting result of such a heterostructure engineering is probably the one that leads to appearance of a new magnetic structure, the so-called pure spin-density wave (SDW) material exhibiting properties of an AFM metal [6–11]. Such heterostructures are found to manifest very unusual properties (both magnetic and transport related). In particular, it has been successfully proven experimentally [10, 11] that depositing LNO thin film on LaAlO_3 (LAO) substrate results in appearance of a rather robust AFM order inside LNO/LAO superstructure (with Neel temperature $T_N \simeq 100 \text{ K}$) due to formation

of SDW and concomitant charge redistribution in LNO films [7].

In this Letter we present our latest measurements of resistivity in (100) -oriented LNO thin films deposited on (100) -oriented LAO substrate by using the pulsed laser deposition (PLD) technique. We demonstrate that our data can be very well fitted by a rather simple law $\rho(T) = A + BT^{3/2}$ for the entire temperature interval ($20 \text{ K} < T < 300 \text{ K}$). We argue that such a temperature dependence is a result of strong resonant scattering of conducting electrons on thermally excited AFM spin fluctuations (taking place inside LNO/LAO hybrid structure) which completely suppresses all the other scattering mechanisms (such as electron–phonon and electron–electron interactions).

2. EXPERIMENTAL

Recall that PLD technique is especially suitable for providing high quality samples with atomically smooth surfaces whose composition agrees well with that of the target and the films can be deposited at a wide range of oxygen pressure. Therefore, PLD technique was employed to deposit thin films of LNO on (100) oriented LAO substrate with typical dimensions of $5 \times 5 \times 0.5 \text{ mm}$. Laser wavelength and repetition rate were $\lambda = 248 \text{ nm}$ (KrF laser with 25 ns pulse duration) and $f = 2 \text{ Hz}$, respectively.

¹ The article is published in the original.

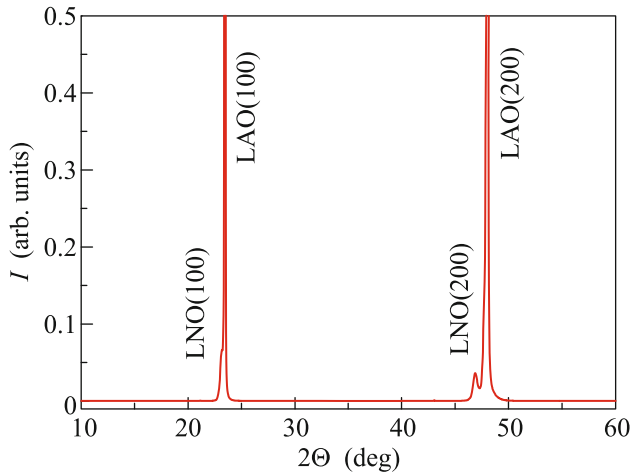


Fig. 1. (Color online) X-ray diffraction spectrum of LNO films deposited on oriented LAO substrate.

Microstructure and crystallographic orientation of the films were characterized by X-ray diffraction (XRD) scans. The surface morphology was confirmed by atomic force microscopy and scanning electron microscopy (these results and further details will be presented elsewhere). XRD pattern of the discussed here LNO/LAO hybrid structure (with LNO thickness of $t = 60$ nm) is depicted in Fig. 1.

The electrical resistivity $\rho(T)$ was measured using the conventional four-probe method. To avoid Joule and Peltier effects, a dc current $I = 100 \mu\text{A}$ was injected (as a one second pulse) successively on both sides of the sample. The voltage drop V across the sample was measured with high accuracy by a KT256 nanovoltmeter.

3. RESULTS AND DISCUSSION

Figure 2 shows the typical results for the temperature dependence of the resistivity $\rho(T)$ in our $\text{LaNiO}_3/\text{LaAlO}_3$ thin films heterostructure. Figure 3 presents the best fit of the experimental data for *all* temperatures according to the following fitting expression: $\rho(T) = A + BT^{3/2}$ with $A = 50 \mu\Omega \text{ cm}$ and $B = 0.0033 \mu\Omega \text{ cm/K}^{3/2}$. Given the above discussion on appearance of AFM order in LNO/LAO hybrid structure, it is quite reasonable to assume that the observed temperature behavior can be attributed to the manifestation of strong long-range AFM spin fluctuations (with a characteristic energy $\hbar\omega_{sf} \simeq k_B T_{sf}$ corresponding to low-energy spin dynamics spectrum measured by inelastic neutron scattering experiments).

It should be mentioned that the origin of the overwhelming $T^{3/2}$ dependence due to spin fluctuations in AFM metals with nontrivial topology of the Fermi surface has been discussed before within a detailed microscopic picture [12, 13]. In particular, it has been demonstrated (within a rigorous Boltzmann

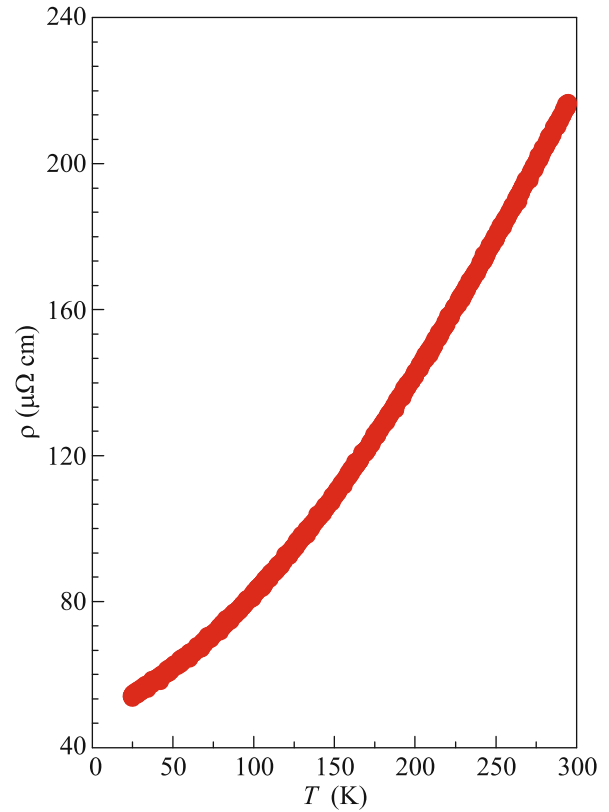


Fig. 2. (Color online) Temperature dependence of the resistivity $\rho(T)$ measured for a typical LaNiO_3 thin film deposited on oriented LaAlO_3 .

approach) that [12] in weakly disordered metals close to AFM quantum-critical point p_c the anisotropic scattering from critical spin fluctuations is strongly influenced by weak (but isotropic) scattering from small amounts of disorder, resulting in a scaling like dependence of magnetoresistivity valid for all temperatures:

$$\rho(T) \propto T^{3/2} F\left[T/\rho_0, (p - p_c)/\rho_0, H/\rho_0^{3/2}\right], \quad (1)$$

where F is a scaling function with ρ_0 the residual contribution (due to impurity scattering), H —the magnetic field, and $p - p_c > 0$ measuring the distance from the quantum-critical point (QCP) on the paramagnetic side of the phase diagram.

A more detailed analysis revealed [12] that at zero magnetic field a 3D system (single crystal) with a small amount of disorder exhibits a resistivity crossover (with increasing the temperature) from $T^{3/2}$ (at low temperatures) to T behavior (at higher temperatures). However, if the system is tuned to the QCP in a finite field, $\rho(T) \propto T^{3/2}$ dependence is expected to be observed at higher temperatures as well. More precisely, it was found [12] that at high enough magnetic fields, the temperature dependence of $\rho(T)$ actually saturates at $T^{3/2}$ at the highest temperatures.

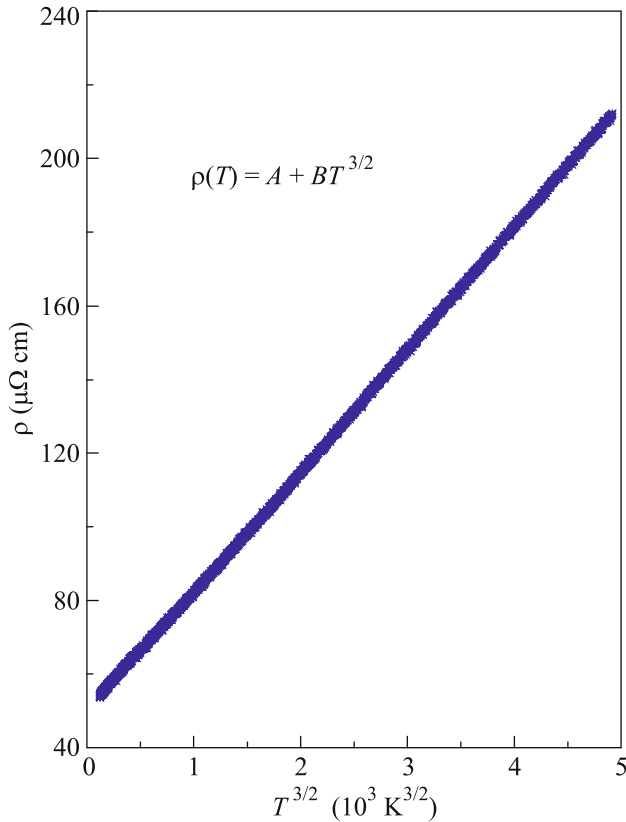


Fig. 3. (Color online) Best fit of the experimental data shown in Fig. 2 according to Eq. (4).

At the same time, a similar $T^{3/2}$ dependence of resistivity has been observed in the high-pressure paramagnetic state of 3D metals and has been attributed to manifestation of small-angle *interband* inelastic scattering by AFM spin fluctuations (cf. Eq. (9) from [13]). Moreover, to explain the universality of the observed $T^{3/2}$ behavior over the entire measured temperatures, it was suggested [13] that the scattering by *intradband* fluctuations replenishes the electron distribution (depleted by *interband* inelastic scattering) while having a little effect on the current, thus making *intradband* scattering mechanism responsible for the robustness of the $T^{3/2}$ behavior in deformed 3D metal.

Based on the above observations and given the well-known fact that thin enough 2D films can be effectively treated as 3D systems under high enough pressure (or equivalent magnetic field), it is quite reasonable to assume that the experimentally observed behavior of resistivity in our “dirty” films can indeed be dominated by AFM spin fluctuations for the entire temperature interval. For simplicity, in this paper we adopt a phenomenological approach based on our previous experience in superconductivity [14]. More specifically, to describe fluctuations induced thermal broadening effects, we suggest the following scenario.

Namely, we introduce the temperature dependence via the cutoff frequency $\Omega(T) = U(T)/\hbar$ which accounts for AFM fluctuations with an average thermal energy $U(T) = \frac{1}{2}C\langle u^2 \rangle \approx k_B T$, where C is the force constant of a two-dimensional harmonic oscillator, and $\langle u^2 \rangle$ is the mean square displacement of the magnetic atoms from their equilibrium positions. As a result, we arrive at the following simple expression for the temperature dependence of resistivity in our hybrid film structure [14]

$$\rho(T) = \rho_0 + \rho_{sf} \left[1 + \int_{\omega_{sf}}^{\omega_{sf} + \Omega(T)} d\omega f(\omega) \right], \quad (2)$$

where $\rho(0) = \rho_0 + \rho_{sf}$ is the total residual contribution, and $f(\omega)$ is an appropriate spectral distribution function.

It should be pointed out that in order to correctly model SDW created fluctuations spectrum in our heterostructure, instead of the previously used Drude–Lorentz law (which is quite appropriate for treating spin fluctuations in superconducting films [14]), we make use of another spectral distribution (which is more suitable for treating spin fluctuations in SDW type materials) valid for $\omega_{sf} \leq \omega \leq \omega_{sf} + \Omega(T)$:

$$f(\omega) = \frac{2}{\pi\omega_{sf}^2} \sqrt{\omega^2 - \omega_{sf}^2}. \quad (3)$$

A careful analysis of Eqs. (2) and (3) reveals that the seeking $T^{3/2}$ law corresponds to a resonance like condition $\omega \simeq \omega_{sf}$ of the above distribution, which becomes $f(\omega) \propto \sqrt{\omega - \omega_{sf}}$ under this condition. It can be directly verified now that the resonant like SDW governed spectrum indeed results in the observed dependence of the resistivity

$$\rho(T) = A + BT^{3/2} \quad (4)$$

with

$$B = \frac{4\sqrt{2}}{3\pi} \left(\frac{k_B}{\hbar\omega_{sf}} \right)^{3/2} \rho_{sf} \quad (5)$$

and $A = \rho_0 + \rho_{sf}$.

Notice that according to Eq. (5), the absolute value of the resonance frequency ω_{sf} in the spectrum of SDW driven AFM fluctuations (dominating the scattering mechanism) can be estimated if we know the value of the residual contribution ρ_{sf} due to electron scattering by spin fluctuations, which is expected to be rather small in comparison with residual contribution ρ_0 due to electron scattering by impurities (very much like in superconducting films [14]). In turn, the latter contribution can be estimated as follows [14]: $\rho_0 = 1/\omega_p^2 \epsilon_0 \tau_0$, where ω_p is the plasmon frequency, $1/\tau_0$ is the elastic scattering rate, and $\epsilon_0 = 8.85 \times 10^{-12}$ F/m is the vac-

uum permittivity. Using [5] $\hbar\omega_p \simeq 1.1$ meV and $1/\tau_0 \simeq 1.2 \times 10^7$ s⁻¹ for our heterostructure, we obtain $\rho_0 \simeq 40$ $\mu\Omega$ cm. Now, using the experimentally found value of $A = \rho_0 + \rho_{sf} = 50$ $\mu\Omega$ cm, we obtain $\rho_{sf} = A - \rho_0 \simeq 10$ $\mu\Omega$ cm for the seeking estimate. With this value in mind and recalling that $B = 0.0033$ $\mu\Omega$ cm/K^{3/2}, from Eq. (5) we can estimate now the value of the resonance frequency ω_{sf} . The result is as follows, $\hbar\omega_{sf} \simeq 2.1$ meV, which gives $T_{sf} \simeq 23$ K for the onset temperature where spin fluctuations begin to dominate the scattering process in our LaNiO₃/LaAlO₃ thin films heterostructure, in a good agreement with the observations (cf. Fig. 2). However, in order to further check a plausibility of the presented here scenario and to corroborate the obtained here results, it is important to relate the resonant frequency ω_{sf} with the inelastic neutron scattering data on low-energy spin dynamics (for the energy spectrum ranging from 0.5 to 5 meV) in such hybrid structures. It is interesting to notice that for our samples $\omega_{sf} \simeq 2\omega_p$.

And finally, it is worthwhile to mention that somewhat similar unusual magnetic properties have been observed in other topologically nontrivial systems, including quasi 1D conducting polymers with AFM ground state (where SDW like spin transport is mediated by topological solitons [15]) and highly ordered artificially prepared 2D arrays of Josephson junctions (exhibiting pronounced geometrical quantization effects [16]).

In summary, a universal $\rho(T) \propto T^{3/2}$ dependence of resistivity for the entire temperature interval was observed in LaNiO₃ thin films grown on oriented LaAlO₃ substrate (by using a pulsed laser deposition technique) and attributed to resonant scattering of conducting electrons on spin fluctuations resulting in thermally activated displacement of magnetic atoms.

We are indebted to the referee for very useful comments, which helped us to better understand the results obtained. This work was financially supported by Brazilian agencies FAPESQ (DCRPB), FAPESP and CNPq. We are very thankful to CEPID/CMDMC/INCTMN and FAPESP (process nos. 2013/07296-2 and 2014/01371-5) for continuous support of our project on nickelates.

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